

| L Number | Hits | Search Text   | DB  | Time stamp       |
|----------|------|---|---|------------------|
| -        | 2418 | low-k or low-dielectric or ((low adj (k or constant)) near3 dielectric)   | USPAT;<br>US-PGPUB;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | 2002/10/29 14:20 |
| -        | 569  | (photoresist or via or via-hole) near10 poison\$4   | USPAT;<br>US-PGPUB;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | 2002/10/29 14:20 |
| -        | 83   | (low-k or low-dielectric or ((low adj (k or constant)) near3 dielectric)) and ((photoresist or via or via-hole) near10 poison\$4) | USPAT;<br>US-PGPUB;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | 2002/10/29 14:36 |

?show files; ds; t/free/1-5\

File 2:INSPEC 1969-2002/Oct W4  
(c) 2002 Institution of Electrical Engineers  
File 3:INSPEC 1969-1982  
(c) 1993 Institution of Electrical Engineers  
File 4:INSPEC 1983-2002/Oct W4  
(c) 2002 Institution of Electrical Engineers

| Set | Items | Description   |
|-----|-------|---|
| S1  | 10    | SOLVENT AND (H2O OR WATER) AND (ARC OR ARL OR ANTIREFLECT?<br>OR ANTI-REFLECT? OR FLARE OR HSQ OR BARL OR CD11 SOG OR BCB OR<br>BENZOCYCLOBUTENE) |
| S2  | 5     | RD (unique items)   |